

Annex 4: Test setup photographs to
TEST REPORT
No.: 17-1-0133807T02a

According to:
Title 47
FCC Regulations Subpart 15C
§15.225

ISED-Regulations
RSS-Gen, Issue 5
RSS-210, Issue 9

for

WITTE - Velbert GmbH & Co. KG

DAG SDH TAG3 NFC
Outer Door Handle with NFC

FCC ID: V2T-SDHTAG3NFC
ISED ID: 7575A-SDHTAG3NFC



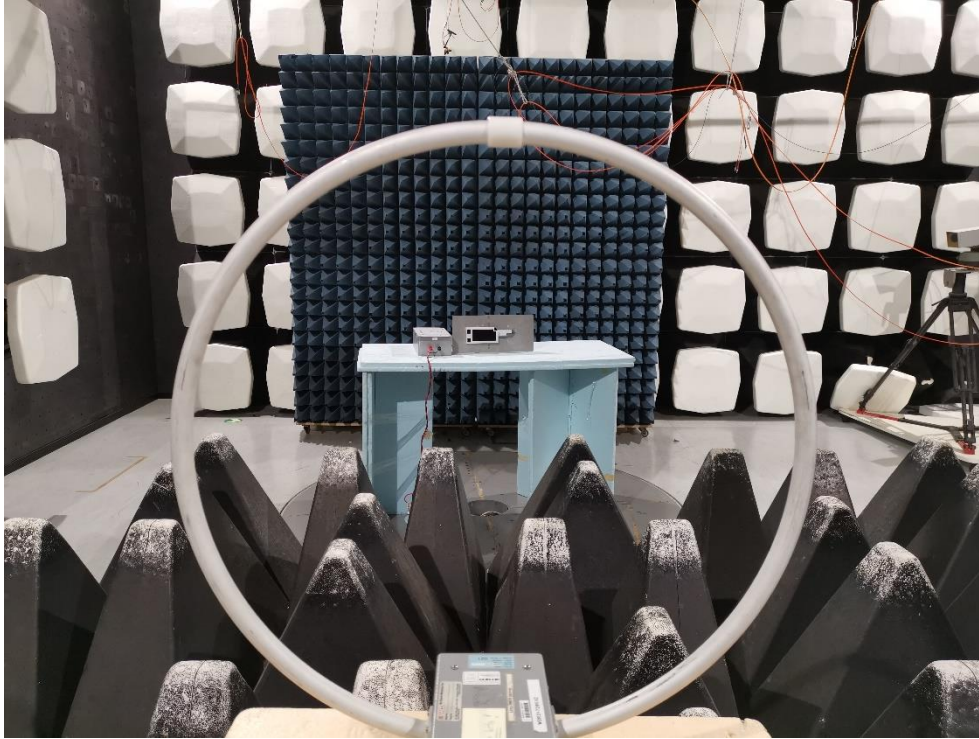
Laboratory Accreditation and Listings
  <p>Deutsche Akcreditierungsstelle D-PL-1202-7-01-01 D-PL-1202-7-01-03 D-PL-1202-7-01-04</p>
Accredited EMC-Test Laboratory
accredited according to DIN EN ISO/IEC 17025
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1. Test setup photographs

1.1. RF measurement in frequency range from 9 kHz to 30 MHz

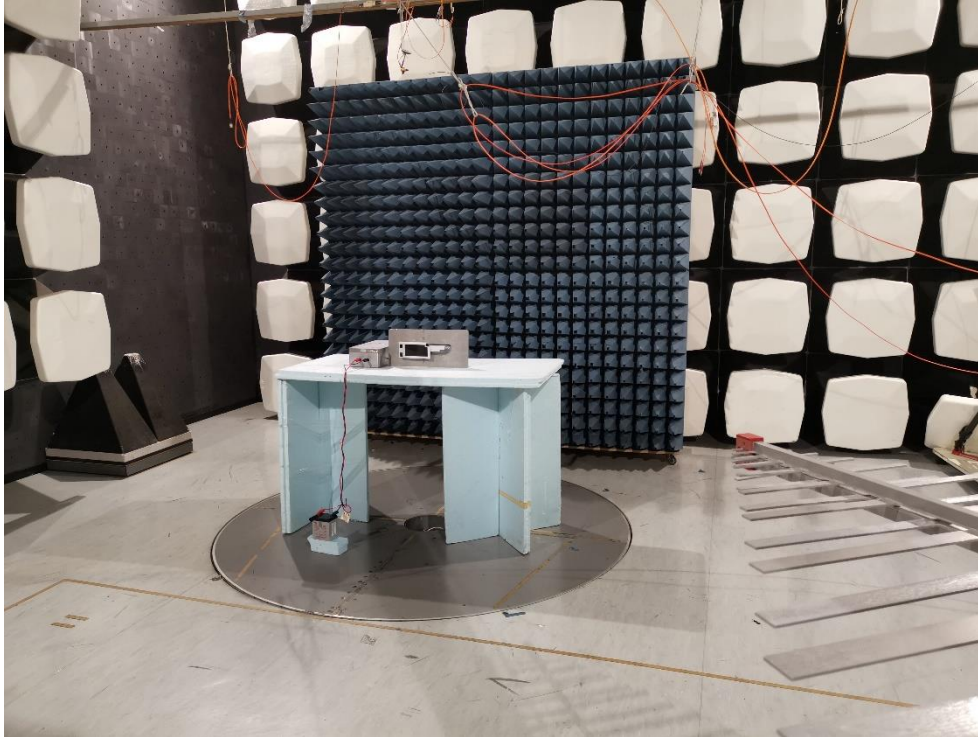


Photograph 1: Overall view of the test setup in the semi-anechoic chamber. EUT stands.



Photograph 2: Close view of the test setup in the semi-anechoic chamber. EUT stands.

1.2. RF measurement in frequency range from 30 MHz to 1 GHz

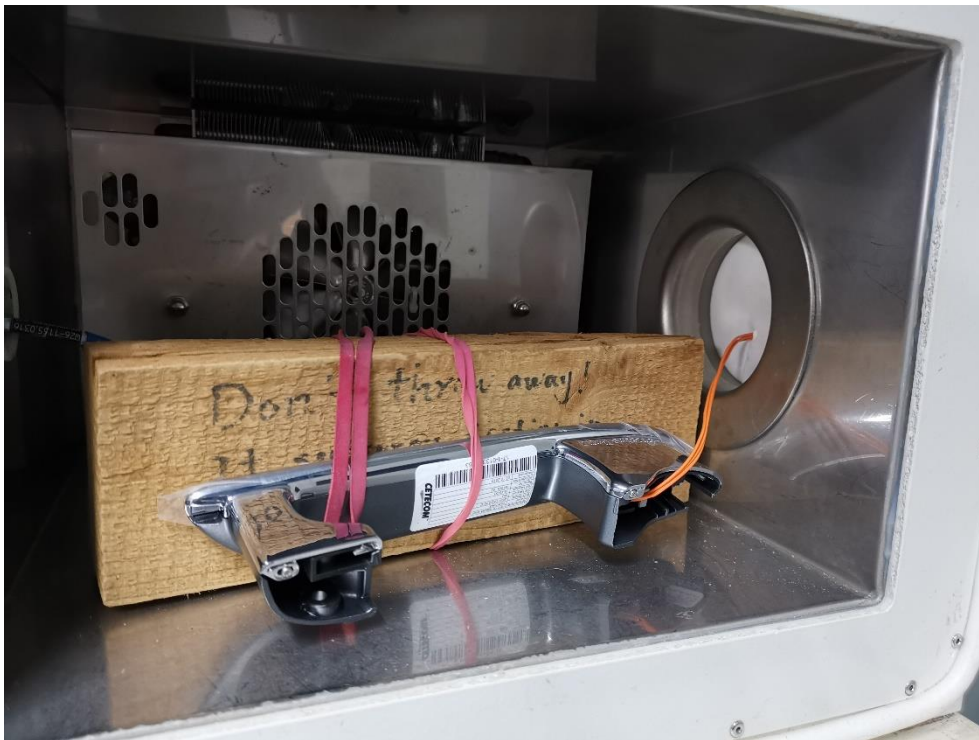


Photograph 3: Overall view of the test setup in the semi-anechoic chamber. EUT stands.

1.3. RF measurement under extreme conditions



Photograph 4: Overall view of the test setup in the climatic chamber.



Photograph 5: Close view of the test setup in the climatic chamber.

----- **End of the Annex 4** -----